JC20 Rec'd PCT/PT 3 MAYT2005 OF 1

Form PTO 144 (Modified)	9	U.S. DEPARTMEN PATENT AND TRA	T OF COMMERCE ADEMARK OFFICE	271693US2PCT		New U.S. PCT Application Based on PCT/JP03/14114			
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Tatsuo NAGANUMA, et al.					
			FILING DATE Herewith		GROUP				
				U.S. PATENT DOCUMENTS					
EXAMINE!	₹	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
	AA								
	AB				<u> </u>				
	AC								
	AD	_							
	AE								
	AF								
	AG							_ ·- · · · · · · · · · · · · · · · · · ·	
	AH				<u> </u>				
	Al	<u></u>							
	AJ				_				
	AK							· · · · · · · · · · · · · · · · · · ·	
	AL								
	AM								
	AN	<u>L.</u>							
			FO	REIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	•	TRANSLATION YES NO			
/MS/	AO	10-043695	02/17/98	JP(with English abstract)				NO	
1	AP	15151/1989	01/25/89	JP				NO	
`	AQ	04-054441	02/21/92	JP(with English abstract)				NO	
	AR	10-318931	12/04/98	JP(with English abstract)				NO	
	AS	09-304412	11/28/97	JP(with English abstract)				NO	
/MS/	AT	10-300680	11/13/98	JP(with English abstract)				NO	
	AU		<u> </u>						
	AV								
		OTHER R	REFERENCES	Including Author, Title, Date, Pertine	nt Pages, e	tc.)			
	AW			_					
	AX								
	AY				_				
	AZ			Additional References sheet(s) attached					
Examiner	/Ñ	/lichael Stafira/			Date Co	Date Considered 03/14/2007			
*Examiner:	Initial if o	reference is considered of considered. Include	I, whether or no	t citation is in conformance with MPEP of with next communication to applicant.	609; Draw li	ne through	citation if	not in	